

Notice of References Cited	Application/Control No. 10/668,454	Applicant(s)/Patent Under Reexamination WU ET AL.	
	Examiner Khiem D. Nguyen	Art Unit 2823	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0081817	06-2002	Bhakta et al.	438/424
*	B	US-6,596,607	07-2003	Ahn, Dong-Ho	438/424
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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